

**Features:**

- n Low  $V_{CE(sat)}$  trench IGBT technology
- n Low switching losses
- n 10 $\mu$ s short circuit capability
- n  $V_{CE(sat)}$  with positive temperature coefficient

**Typical Applications:**

- n AC inverter drives mains 575-750V AC
- n Public transport (auxiliary syst.)

SYMBOL	CHARACTERISTIC	TEST CONDITIONS	VALUE			UNIT	
			Min	Type	Max		
$V_{CES}$	Collector-Emitter voltage	$T_j=25^\circ\text{C}$			1700	V	
$V_{GES}$	Gate-Emitter voltage	$T_j=25^\circ\text{C}$			$\pm 20$	V	
$I_C$	Collector current	Continuous@ $T_C=80^\circ\text{C}$			75	A	
$I_{CP}$		$T_P=1\text{ms}$			150	A	
$P_D$	Maximum Power Dissipation	$T_j=175^\circ\text{C}$ , 1 device			600	W	
$T_j$	Junction temperature	/			175	$^\circ\text{C}$	
$T_{stg}$	Storage temperature	/	-40		125	$^\circ\text{C}$	
$V_{iso}$	Isolation between terminal and copper base	$T_j=25^\circ\text{C}$ , AC: 1minute	4000			V	
Screw torque	Mounting(M5)	/	2.5		5.0	N·m	
	Terminals(M6)	/	3.0		5.0	N·m	
$I_{CES}$	Zero gate voltage collector current	$T_j=25^\circ\text{C}$ , $V_{CE}=1700\text{V}$ , $V_{GE}=0\text{V}$			3.0	mA	
$I_{GES}$	Gate-Emitter leakage current	$T_j=25^\circ\text{C}$ , $V_{CE}=0\text{V}$ , $V_{GE}=\pm 20\text{V}$			$\pm 0.4$	$\mu\text{A}$	
$V_{GE(th)}$	Gate-Emitter threshold voltage	$T_j=25^\circ\text{C}$ , $V_{CE}=20\text{V}$ , $I_C=3\text{mA}$	5.2	5.8	6.4	V	
$V_{CE(sat)}$	Collector-Emitter saturation voltage	$T_j=25^\circ\text{C}$ , $V_{GE}=15\text{V}$ , $I_C=75\text{A}$		2.0		V	
		$T_j=125^\circ\text{C}$ , $V_{GE}=15\text{V}$ , $I_C=75\text{A}$		2.4		V	
$R_{Gint}$	Internal gate resistor	$T_j=25^\circ\text{C}$		8.5		$\Omega$	
$C_{ies}$	Input capacitance	$T_j=25^\circ\text{C}$ , $V_{CE}=25\text{V}$ , $V_{GE}=0\text{V}$ , $f=1\text{MHz}$		6.80		nF	
$C_{res}$	Reverse transfer capacitance			0.22		nF	
$t_{on}$	Turn-on time	$T_j=125^\circ\text{C}$ , $V_{CC}=900\text{V}$ , $I_C=75\text{A}$ , $V_{GE}=\pm 15\text{V}$ , $R_g=6.8\Omega$ , Inductive load		400		ns	
$t_r$				50		ns	
$t_{off}$	Turn-off time			800		ns	
$t_f$				300		ns	
$E_{on}$	Turn-on energy loss per pulse			24.0		mJ	
$E_{off}$	Turn-off energy loss per pulse			23.5		mJ	
$I_{sc}$	SC data		$V_{GE}=15\text{V}$ , $V_{CC}=1000\text{V}$ , $t_{sc}\leq 10\mu\text{s}$ , $T_{vj}=125^\circ\text{C}$ , $V_{CEM}\leq 1700\text{V}$		300		A
tsc	Short circuit withstand time		$T_j=125^\circ\text{C}$	10			$\mu\text{s}$

V <sub>F</sub>	Forward on voltage	T <sub>J</sub> =25°C, I <sub>F</sub> =75A	1.80	V
		T <sub>J</sub> =125°C, I <sub>F</sub> =75A	1.90	V
I <sub>RM</sub>	Peak reverse recovery current	I <sub>F</sub> =75A, -diF/dt=1800 A/μs, V <sub>R</sub> =900V, V <sub>GE</sub> =-15V, T <sub>J</sub> =125°C	125	A
Q <sub>r</sub>	Recovered charge		36.5	μC
E <sub>rec</sub>	Reverse recovery energy		20.5	mJ
R <sub>th(j-c)</sub>	Thermal resistance(1 device)	IGBT	0.25	°C/W
		FWD	0.46	°C/W
R <sub>th(c-f)</sub>	Contact thermal resistance (1 device)	With thermal compound	0.050	°C/W
W <sub>t</sub>	Weight		150	g
Outline	251H3P			

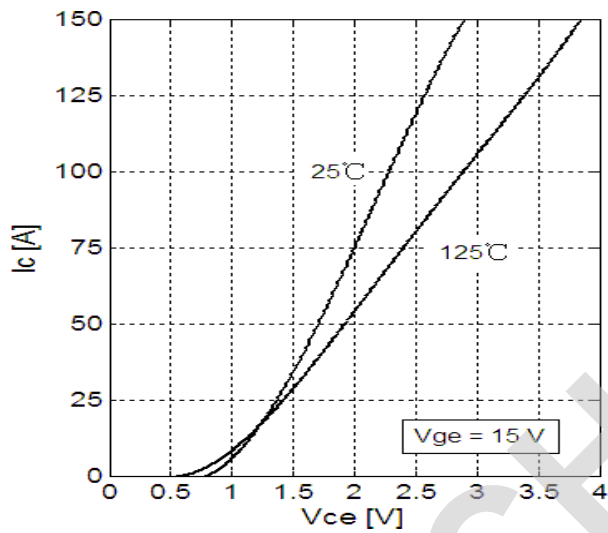


Fig 1. IGBT Typical Output Characteristics

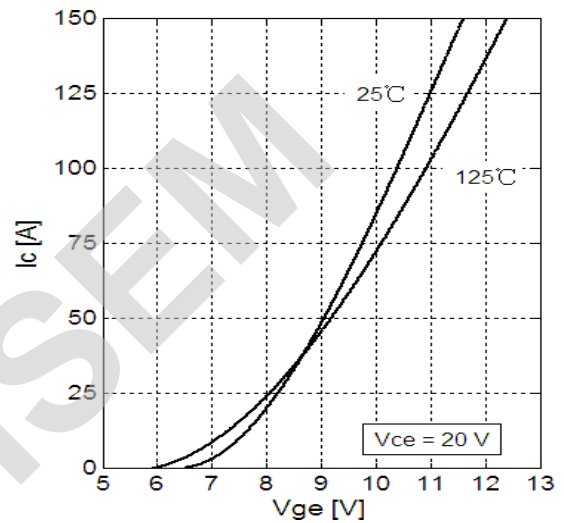


Fig 2. IGBT Typical Transfer Characteristics

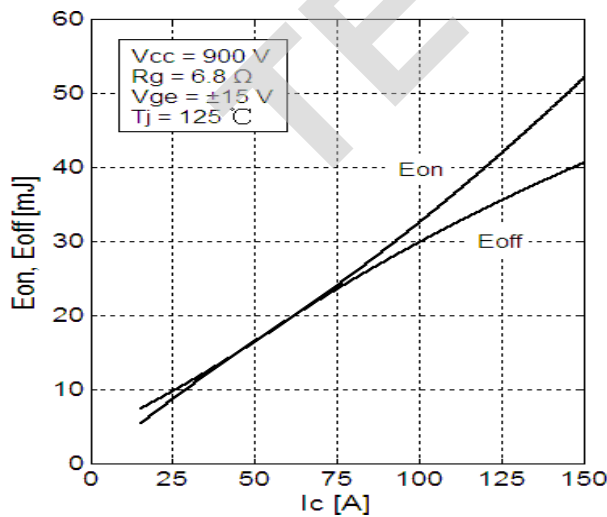


Fig 3. IGBT Switching Loss vs. Collector Current

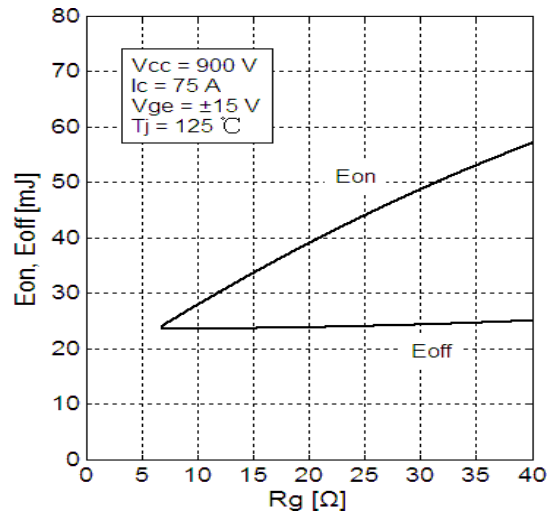


Fig 4. IGBT Switching Loss vs. Gate Resistor

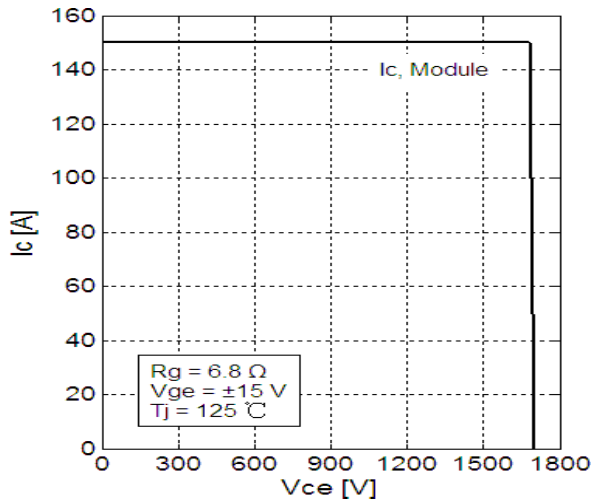


Fig 5. RBSOA

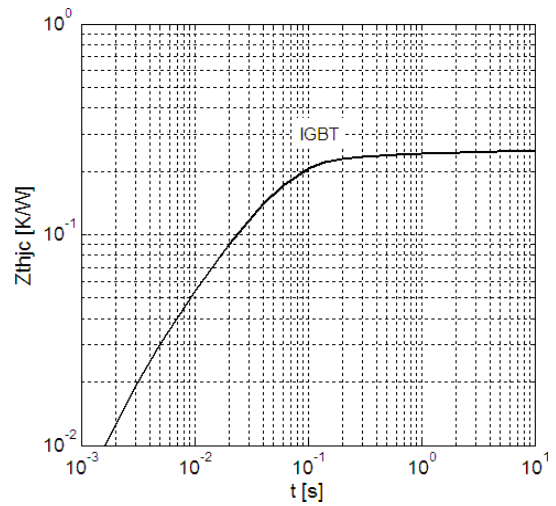


Fig 6. IGBT Transient Thermal Impedance

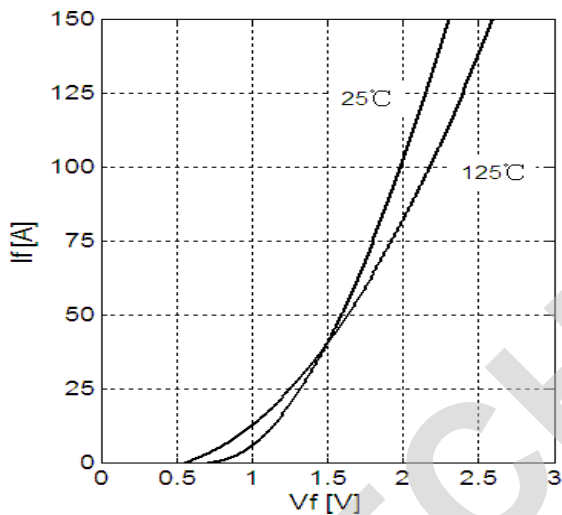


Fig 7. Forward Characteristics of Diode

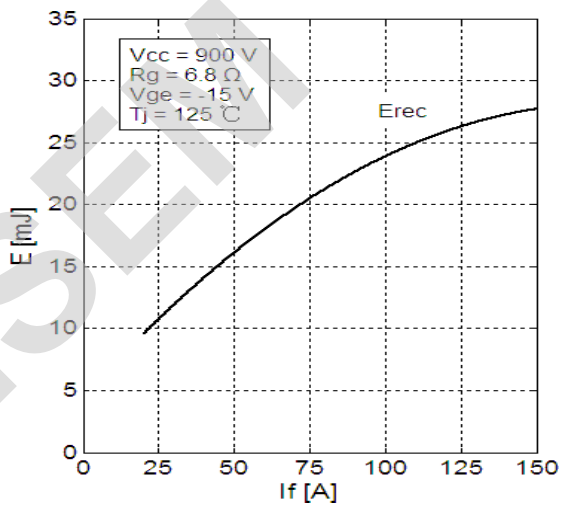


Fig8. Diode Switching Loss vs. Collector Current

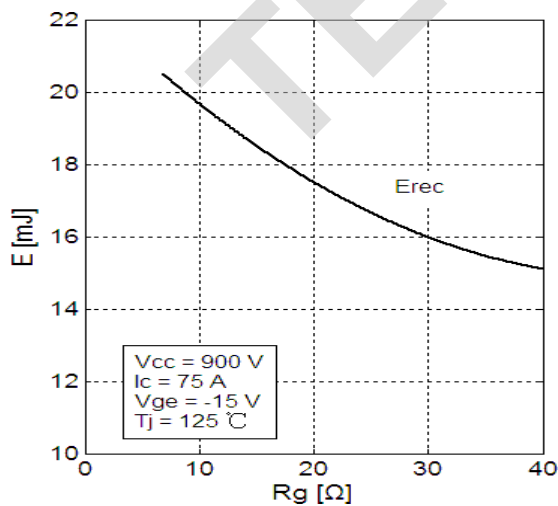


Fig9. Diode Switching Loss vs. Gate Resistor

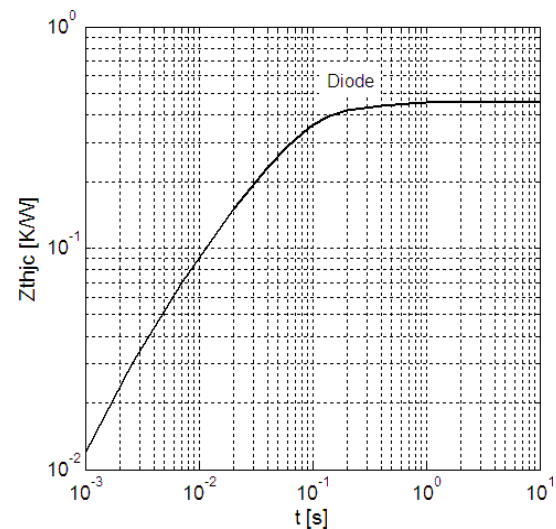


Fig 10. Diode Transient Thermal Impedance

Outline & Circuit Diagram

